

FIG. 1

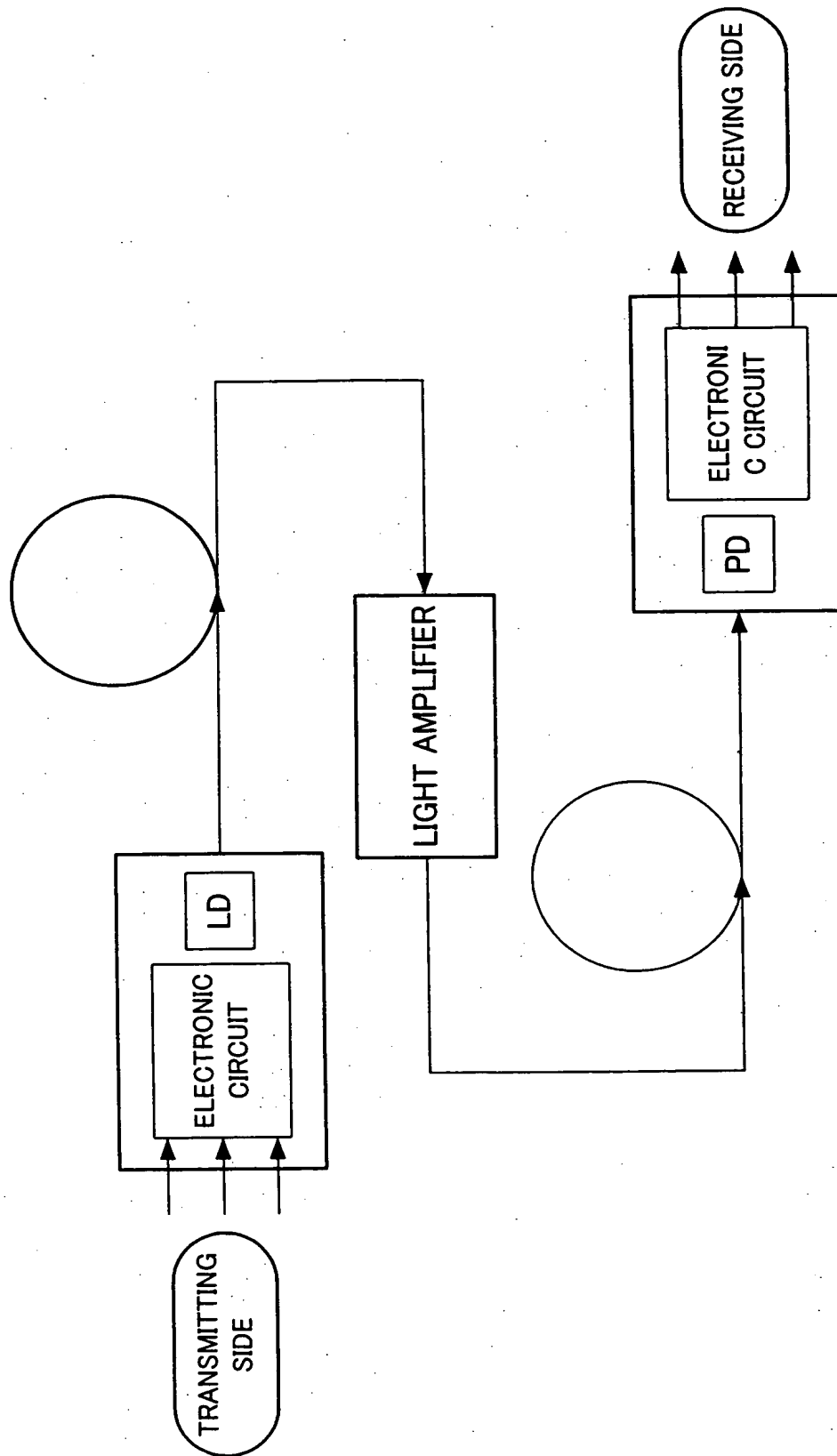


FIG. 2

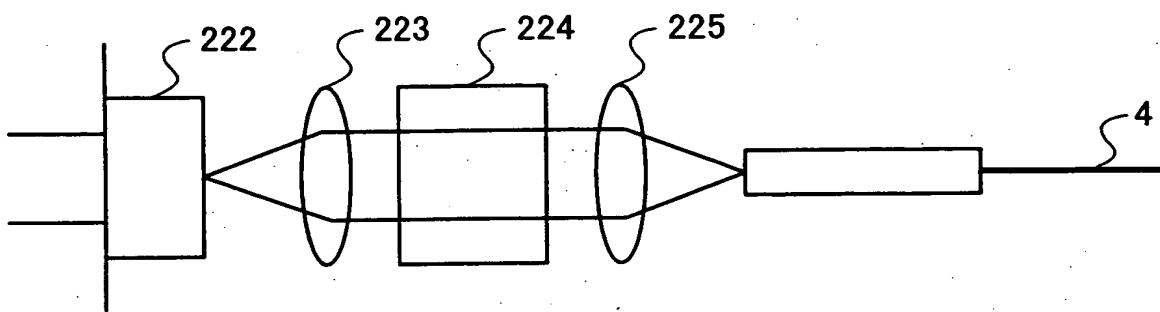


FIG. 3A

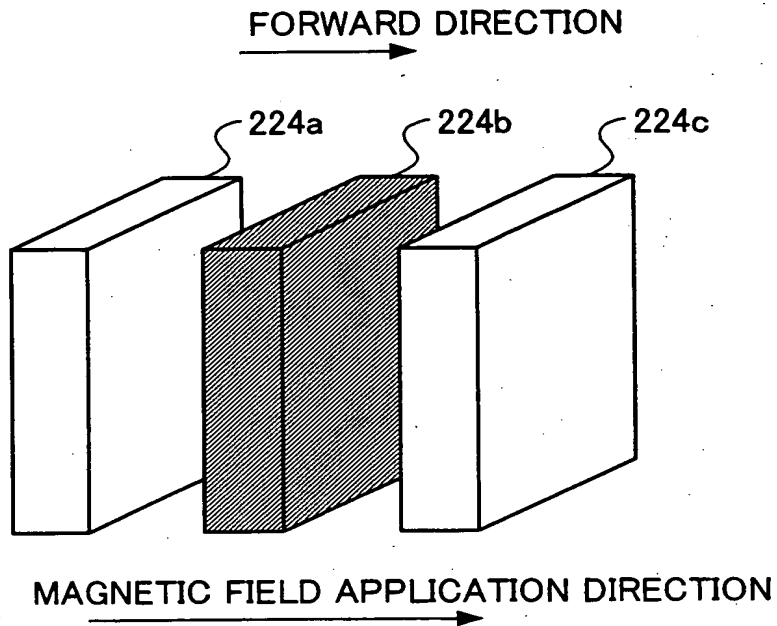


FIG. 3B

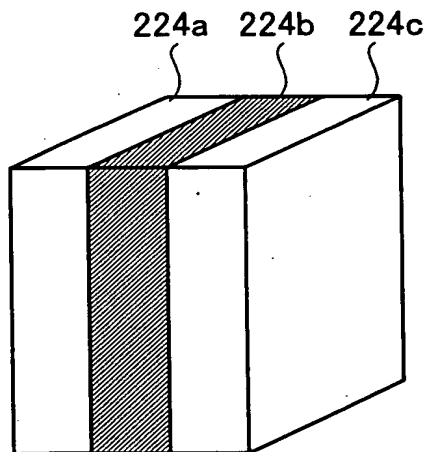


FIG. 4

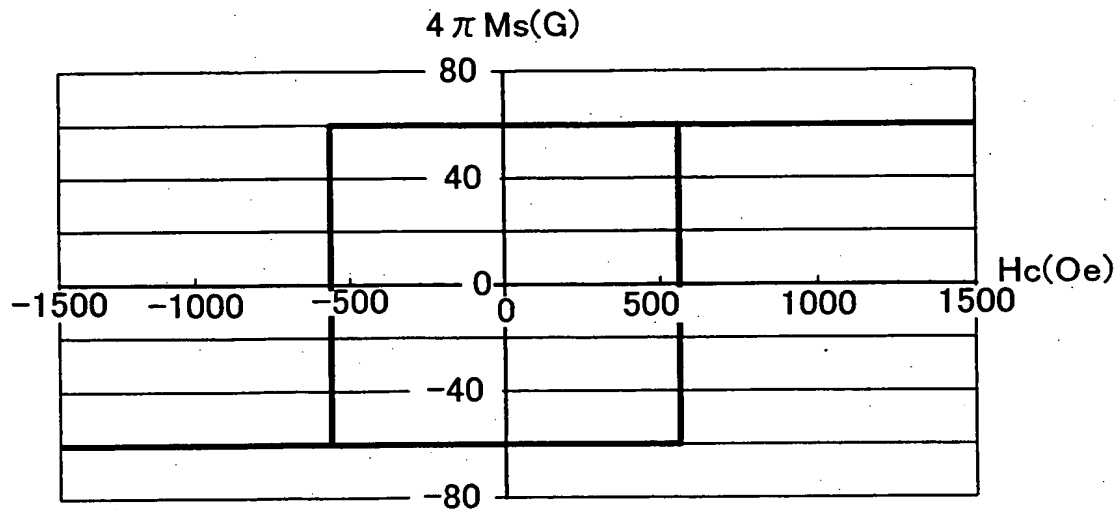


FIG. 5

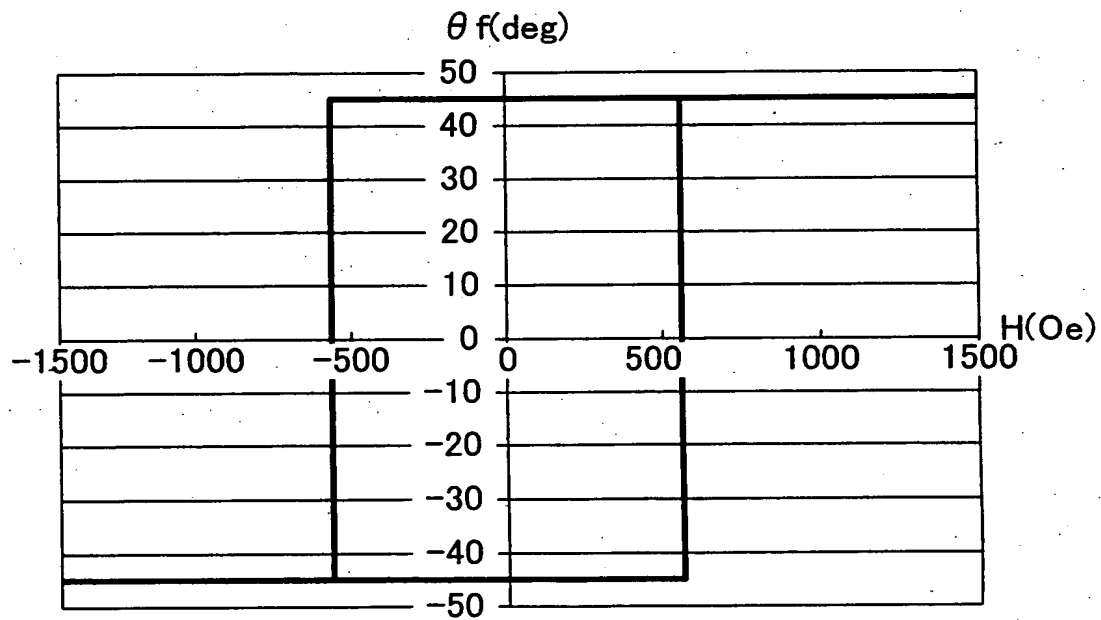


FIG. 6

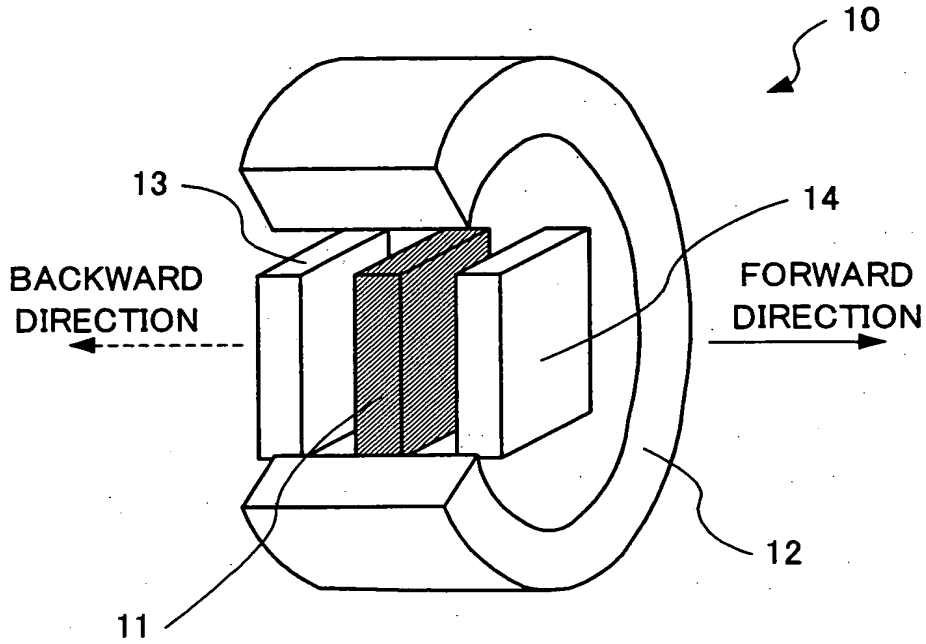


FIG. 7A

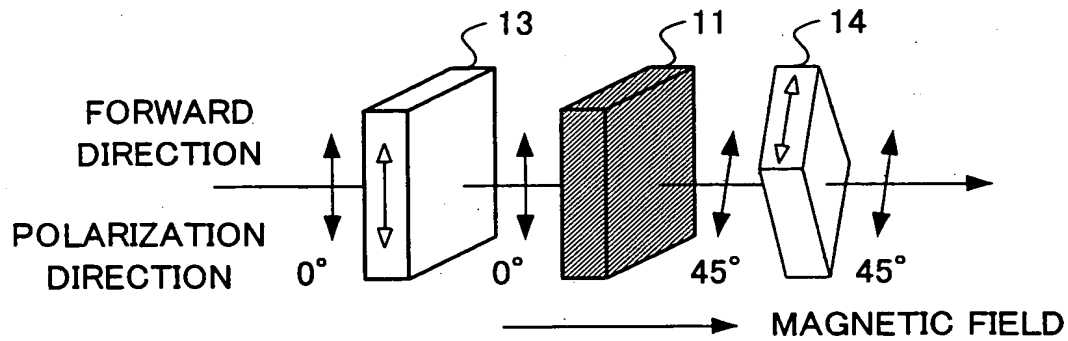


FIG. 7B

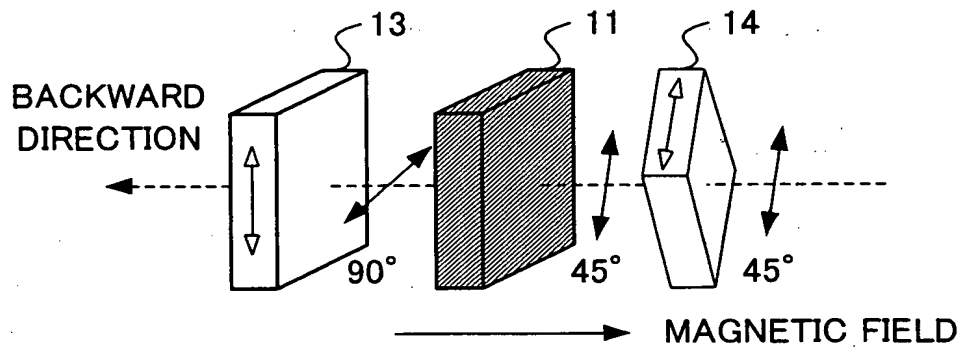


FIG. 8

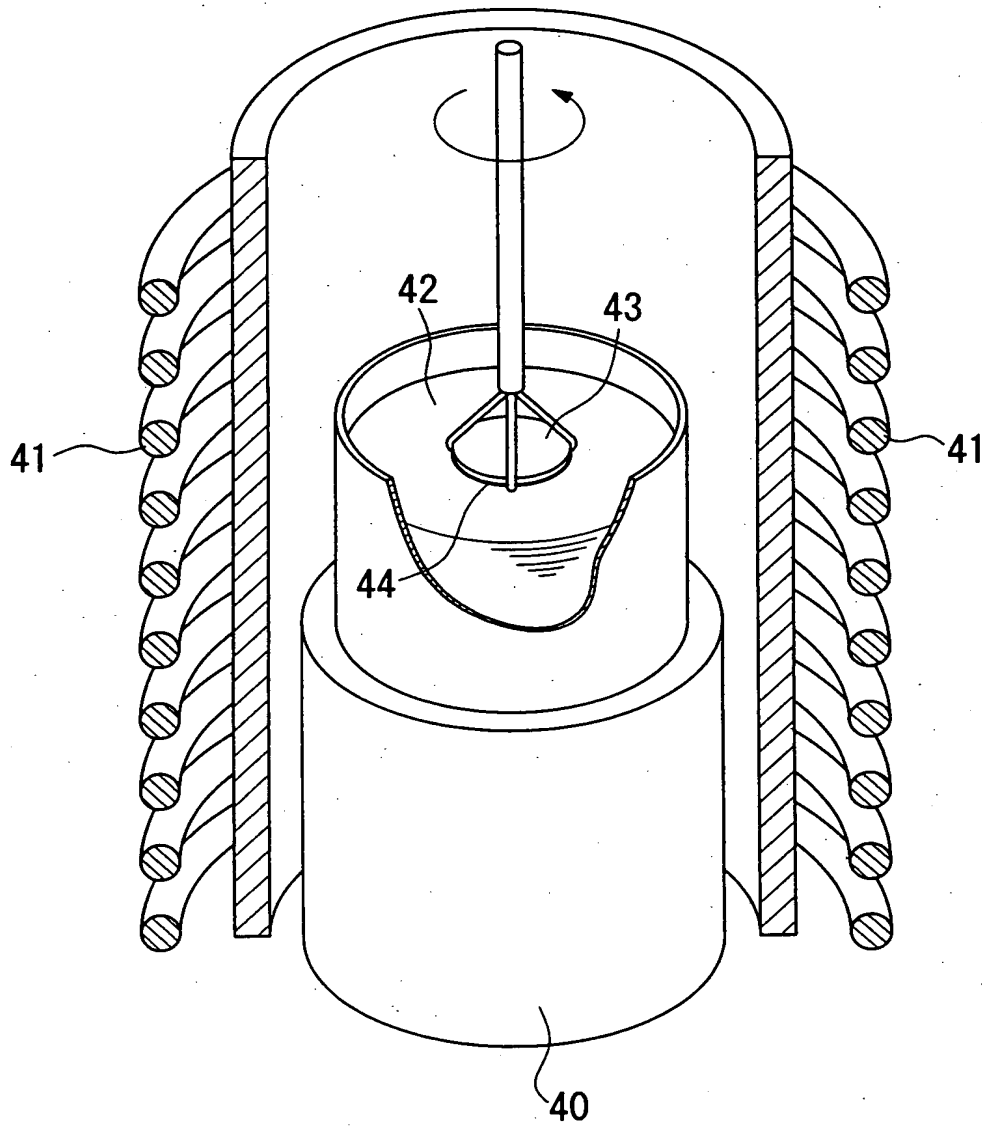


FIG. 9

SAMPLE No.	CHEMICAL COMPOSITION	ROTARY MOMENT (° / cm)	TEMPERA- TURE PROPERTY		WAVE- LENGTH PROPERTY		INSERTION LOSS (dB)	MAGNE- TIC TYPE	REMARKS
			(%)	(° / °C)	(%)	(° / nm)			
1	Bi _{1.0} Gd _{0.4} Tb _{1.2} Yb _{0.4} Fe _{4.0} Ga _{1.0} O ₁₂	800	10.8 0.078	6.8 0.061		0.07	HARD MAGNETIC	PRESENT INVENTION	
2	Bi _{1.2} Tb _{1.4} Y _{0.4} Fe _{3.8} Ga _{1.2} O ₁₂	950	11.8 0.085	6.8 0.061		0.12	HARD MAGNETIC	COMPARATIVE EXAMPLE (CONTAINING NO Gd)	
3	Bi _{1.2} Gd _{1.2} Yb _{0.6} Fe _{3.9} Ga _{1.1} O ₁₂	950	13.9 0.100	8.3 0.075		0.02	HARD MAGNETIC	COMPARATIVE EXAMPLE (CONTAINING NO Tb)	
4	Bi _{0.7} Gd _{1.1} Tb _{1.2} Fe _{4.2} Ga _{0.8} O ₁₂	650	10.4 0.075	6.8 0.061		0.07	HARD MAGNETIC	COMPARATIVE EXAMPLE (CONTAINING NO Yb)	
5	Bi _{1.2} Gd _{1.8} Fe _{4.0} Ga _{0.5} Al _{0.5} O ₁₂	800	11.8 0.085	8.2 0.074		0.07	HARD MAGNETIC	JAPANESE PATENT LAID-OPEN No. 6- 222311	
6	Bi _{1.0} Eu _{2.0} Fe _{4.0} Ga _{0.5} Al _{0.5} O ₁₂	800	13.9 0.100	8.3 0.075		0.04	HARD MAGNETIC	JAPANESE PATENT LAID-OPEN No. 9- 185027	
7	Bi _{1.37} Tb _{1.63} Fe _{4.0} Ga _{0.84} Al _{0.15} O ₁₂	1050	10.0 0.072	6.7 0.060		0.11	HARD MAGNETIC	JAPANESE PATENT LAID-OPEN No. 9- 328398	
8	Bi _{1.48} Tb _{1.08} Ho _{0.44} Fe _{4.09} Ga _{0.77} Al _{0.14} O ₁₂	1100	15.3 0.110	6.9 0.062		0.09	HARD MAGNETIC	JAPANESE PATENT LAID-OPEN No. 10- 31112	
9	Bi _{1.0} Gd _{0.3} Tb _{1.4} Yb _{0.3} Fe _{4.3} Ga _{0.7} O ₁₂	920	9.7 0.072	6.7 0.060		0.07	HARD MAGNETIC	PRESENT INVENTION	

FIG. 10

SAMPLE No.	CHEMICAL COMPOSITION	ROTARY MOMENT	TEMPERA- TURE PROPERTY		WAVE- LENGTH PROPERTY	INSERTION LOSS	MAGNE- TIC TYPE	REMARKS
			(° / cm)	(%)				
				(° / °C)				
				(° / nm)	(dB)			
1	Bi ₁ Gd _{0.4} Tb _{1.2} Yb _{0.4} Fe _{4.0} Ga _{1.0} O ₁₂	800	10.8	6.8	0.07	HARD MAGNETIC	PRESENT INVENTION (LARGE AMOUNT OF Tb)	
			0.078	0.061				
10	Bi _{1.1} Gd _{0.9} Tb _{0.7} Yb _{0.3} Fe _{4.0} Ga _{1.0} O ₁₂	850	11.4	7.1	0.04	HARD MAGNETIC	PRESENT INVENTION (LARGE AMOUNT OF Gd)	
			0.082	0.064				
11	Bi _{1.2} Gd _{0.5} Tb _{0.8} Yb _{0.5} Fe _{4.0} Ga _{1.0} O ₁₂	950	11.8	7	0.06	HARD MAGNETIC	PRESENT INVENTION (LARGE AMOUNT OF Bi)	
			0.085	0.063				
12	Bi _{1.1} Gd _{0.6} Tb _{0.9} Yb _{0.4} Fe _{4.9} Ga _{0.1} O ₁₂	—	—	—	—	SOFT MAGNETIC	COMPARATIVE EXAMPLE	

FIG. 11

SAMPLE No.	CHEMICAL COMPOSITION	ROTARY MOMENT (° /cm)	TEMPERA- TURE PROPERTY		WAVE- LENGTH PROPERTY	INSERTION LOSS	MAGNE- TIC TYPE	REMARKS
			(%)	(° /°C)				
13	Bi _{1.0} Gd _{0.4} Tb _{1.2} Yb _{0.4} Fe _{4.0} Ga _{0.7} Al _{0.3} O ₁₂	800	10.8	6.8		0.07	HARD MAGNETIC	PRESENT INVENTION
14	Bi _{1.2} Gd _{0.4} Tb _{1.2} Yb _{0.4} Fe _{4.0} Ga _{0.8} Ge _{0.1} Sc _{0.1} O ₁₃	950	11.1	6.9		0.07	HARD MAGNETIC	PRESENT INVENTION
15	Bi _{1.2} Gd _{0.4} Tb _{0.7} Yb _{0.6} Ca _{0.1} Fe _{4.2} Al _{0.5} In _{0.2} Si _{0.1} O ₁₄	950	0.080	0.062		0.06	HARD MAGNETIC	PRESENT INVENTION
16	Bi _{0.9} Gd _{0.7} Tb _{0.7} Yb _{0.3} Sn _{0.2} Eu _{0.2} Fe _{4.5} Ga _{0.4} Ti _{0.1} O ₁₂	770	12.2	7.2		0.10	HARD MAGNETIC	PRESENT INVENTION
17	Bi _{1.0} Gd _{0.5} Tb _{0.5} Yb _{0.5} Dy _{0.3} Lu _{0.2} Fe _{4.0} Ga _{1.0} O ₁₂	800	11.1	7.2		0.09	HARD MAGNETIC	PRESENT INVENTION
18	Bi _{0.9} Gd _{0.9} Tb _{0.7} Yb _{0.4} Tm _{0.3} Fe _{4.1} Ga _{0.9} O ₁₂	770	0.080	0.065		0.095	HARD MAGNETIC	PRESENT INVENTION
19	Bi _{1.1} Gd _{0.6} Tb _{0.9} Yb _{0.2} Er _{0.2} Fe _{4.3} Ga _{0.7} O ₁₂	850	11.1	7.1		0.09	HARD MAGNETIC	PRESENT INVENTION
20	Bi _{1.0} Gd _{0.4} Tb _{1.1} Yb _{0.3} Ho _{0.2} Fe _{4.2} Ga _{0.8} O ₁₂	800	10.8	6.9		0.07	HARD MAGNETIC	PRESENT INVENTION
21	Bi _{0.9} Gd _{1.1} Tb _{0.8} Yb _{0.2} Y _{0.1} Fe _{4.6} Ga _{0.4} O ₁₂	770	0.078	0.062		0.07	HARD MAGNETIC	PRESENT INVENTION

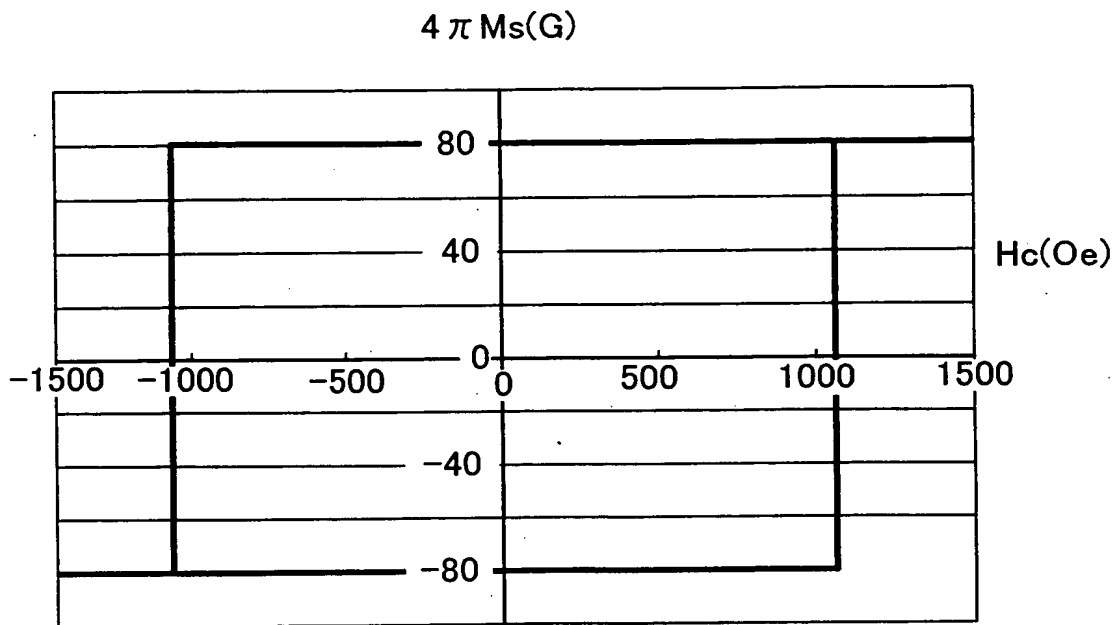


FIG. 12A

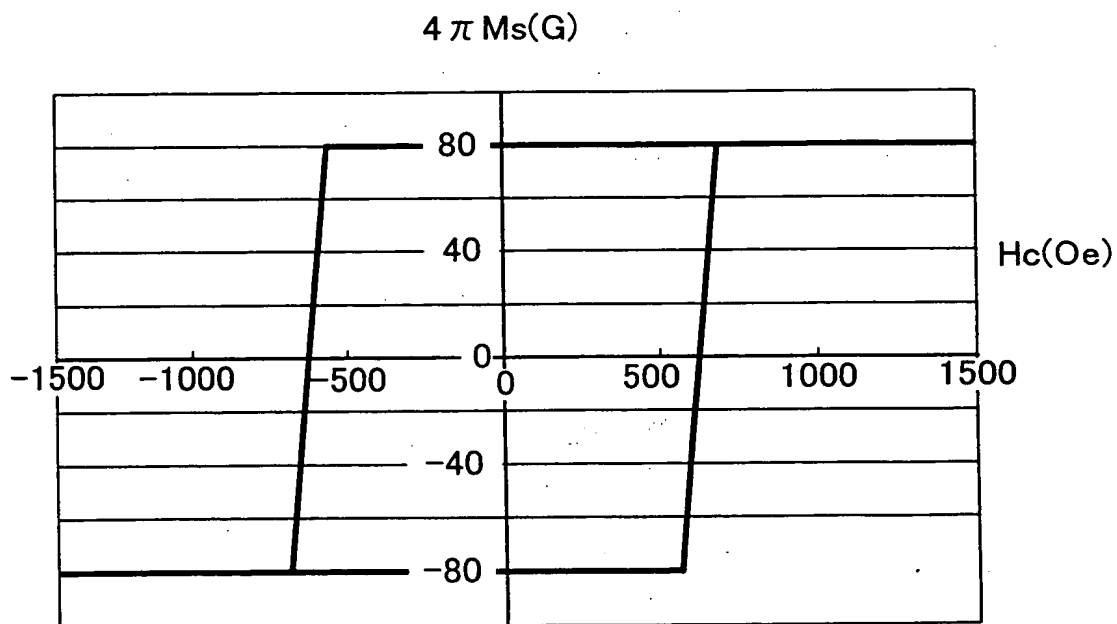


FIG. 12B

FIG. 13

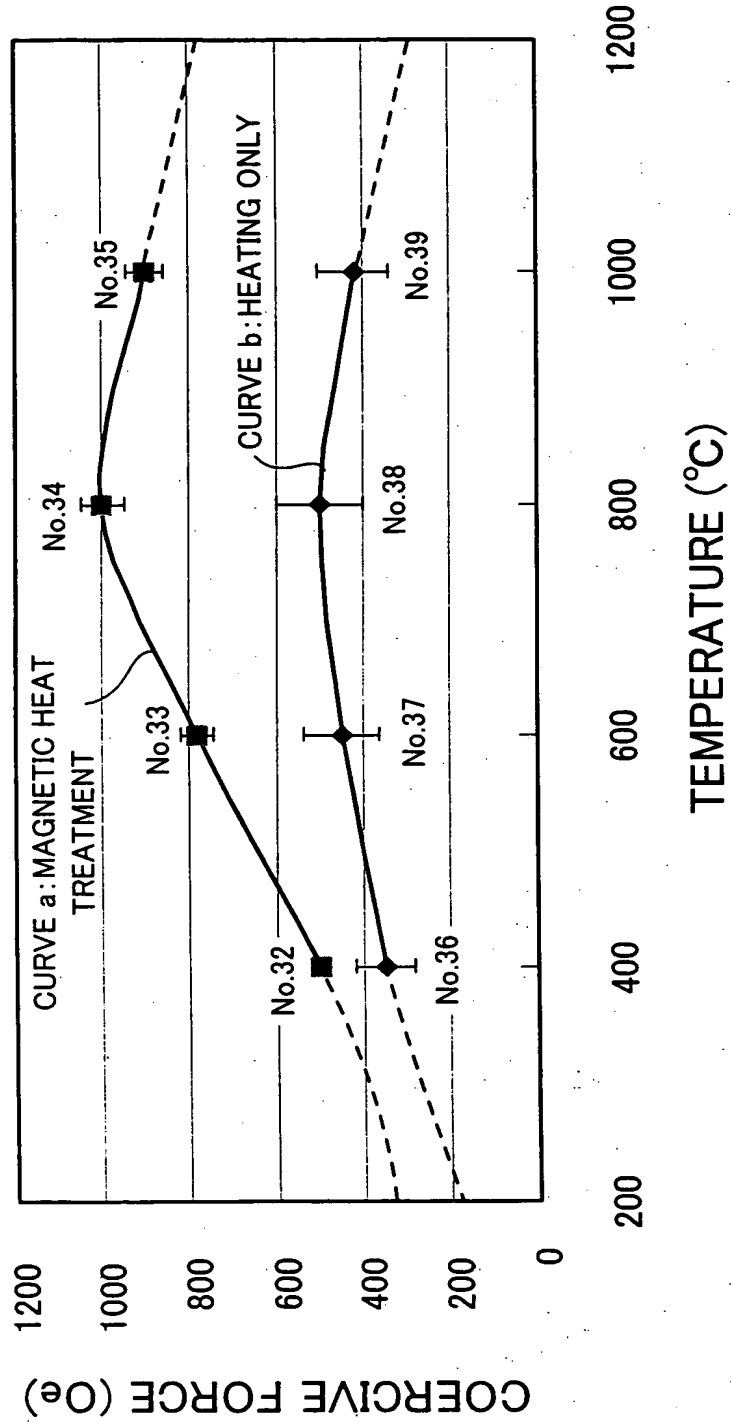


FIG. 14

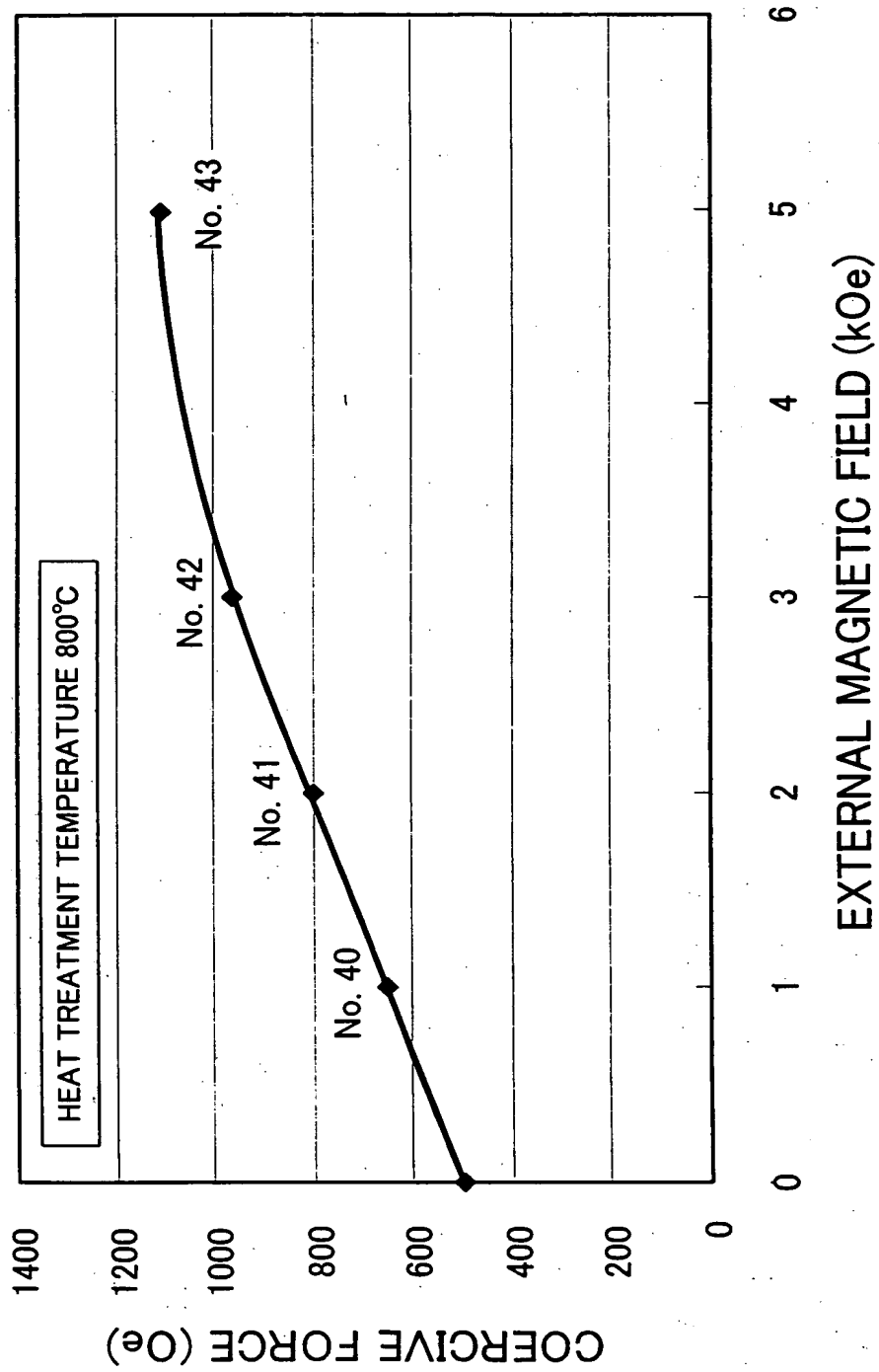


FIG. 15A

SECTION OF A SAMPLE CUT BY WIRE SAW

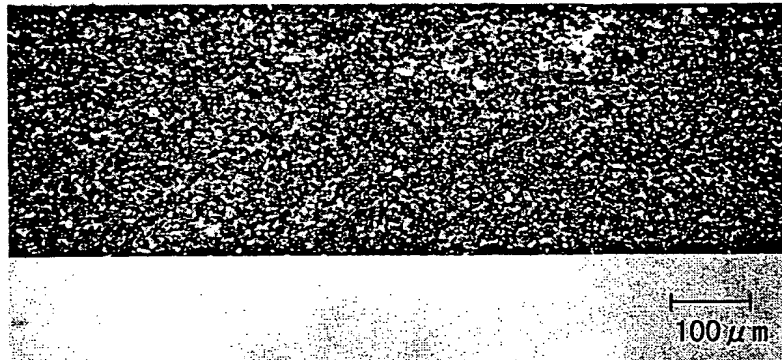


FIG. 15B

SECTION OF A SAMPLE CUT BY DICING MACHINE

